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Experimental Study on Axial Dependence of Anode Current Distribution in an Oven Magnetron

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Abstract—The axial dependence of the anode current distribution in a 2.45-GHz oven magnetron was investigated. We previously demonstrated that installing a cathode shield is an effective way to reduce magnetron noise. The objective of the present study is to determine why installing a cathode shield reduces the noise. We measured the anode current of a test magnetron with an axially segmented anode block. When no magnetic field was applied, the test magnetron behaved like a cylindrical vacuum diode, and the axial electron distribution corresponded to the axial distribution of the cathode temperature. When a magnetic field was applied, the cathode shield increased the normalized anode current in the central region, which contributes to noise reduction.

Index Terms—Cathodes, magnetrons, noise.

I. INTRODUCTION

A MAGNETRON is a well-known crossed-field vacuum device commonly used as a microwave oven heating source. A 2.45-GHz oven magnetron has a high dc–RF conversion efficiency of over 70%, but it also has wideband oscillation, harmonics, $\pi - 1$ -mode oscillation, and spurious noise over a wide frequency range. Additional filtering circuits and noise shielding are thus necessary for microwave ovens to prevent electromagnetic interference with other electrical appliances. Several methods for reducing magnetron noise have been proposed and experimentally demonstrated.

Installing an ion-drain electrode in an oven magnetron effectively suppresses noise generated by ions trapped in the vicinity of the cathode [1]. Magnetic priming [2]–[5] and electric priming [6] reduce start-up noise by hastening π -mode selection. Installing a metal cathode shield has been also investigated as an effective method for reducing magnetron noise. Kohsaka *et al.* have proposed installing cathode shields on both ends of the cathode [7] to reduce magnetron noise. We have experimentally verified that installing a cathode shield on only the high-voltage (HV) input side of the cathode is more effective than installing

Fig. 1. Cross-sectional schematic view of the test magnetron with axially segmented anodes. The anode block of the test magnetron consists of five pieces: pole piece I, anode I, anode C, anode O, and pole piece O.

two cathode shields on both ends of the cathode [8]. Although it causes about 3% degradation of the magnetron efficiency compared to a conventional oven magnetron, the cathode shield is easy to assemble into the magnetron filament and significantly suppresses the sideband noise around the carrier frequency, the $\pi - 1$ -mode oscillation, and spurious noise over a wide frequency range, which can be seen in [8].

The objective of the present study is to determine how a cathode shield reduces the noise. We measured the anode current of a test magnetron with axially segmented anode blocks, in order to estimate the axial dependence of the anode current in an oven magnetron.

II. MEASUREMENT CONFIGURATIONS

A. Test Magnetron

Figs. 1 and 2 show a cross-sectional schematic view and a photograph of the test magnetron, respectively. The labels “HV input side” and “RF output side” in Figs. 1 and 2 indicate the side on which the cathode filament is connected to the input power source and the side on which the RF output probe is located, respectively. The anode block of the test magnetron consists of five segments that surround the cathode filament: the pole piece on the HV input side (pole piece I), the anode block on the HV input side (anode I), the anode block in the

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Fig. 2. Photograph of the test magnetron.

Fig. 3. Schematic cross-sectional views of the test magnetron cathodes. (a) Conventional cathode. (b) Shielded cathode.

central region (anode C), the anode block on the RF output side (anode O), and the pole piece on the RF output side (pole piece O). Anode I, anode C, and anode O all have an axial length of 3 mm. Each anode segment or pole piece is insulated from adjacent anode segment(s) by a ceramic plate to permit the anode current collected by each anode segment to be independently measured.

Two types of magnetron cathodes were examined: a conventional cathode and a shielded cathode. Cross-sectional schematic views of the cathodes are shown in Fig. 3. The configuration of the shielded cathode is the same as that depicted in [8].

Two cases were examined with respect to the external magnetic field: no applied magnetic field and an applied magnetic field of 0.11 T. When no magnetic field is applied, the test magnetron is expected to function like a cylindrical vacuum diode. The magnetic field of 0.11 T is generated by permanent magnets attached to both pole pieces. The magnetic field strength of 0.11 T, which is much smaller than that of commercially available oven magnetrons (approximately 0.18 T), was selected in order to prevent the test magnetron from oscillating. Hence, oscillation of the test magnetron did not occur during the measurements.

Fig. 4. Schematic of the measurement system. V_c is the operating voltage, I_b is the anode current, and I_{bt} is the total anode current.

B. Measurement System

Fig. 4 shows a schematic of the measurement system used for monitoring the anode current to each anode segment or pole piece. The test magnetron is completely enclosed in a vacuum chamber to evacuate the tube. An HV pulsed power supply operated the test magnetron at a pulse frequency of 50 Hz and a duty of 50% with a constant filament current of 10 A. Each anode segment or pole piece was connected to a resistance of 1 Ω , which was placed outside the vacuum chamber. The anode current I_b collected on each anode segment or pole piece was obtained by measuring the voltage across each resistance using an oscilloscope. The total anode current I_{bt} was measured with an ammeter. The operating voltage V_c was also monitored with an oscilloscope.

III. MEASUREMENT RESULTS

A. Case I: No Magnetic Field

With no magnetic field applied, Fig. 5(a) and (b) shows the measurement results for the anode current distribution as a function of the operating voltage V_c for the conventional cathode and the shielded cathode, respectively. The total anode current I_{bt} is 3.2 A in the conventional cathode case and 5.1 A in the shielded cathode case, both at the operating voltage of -5.0 kV.

As seen in Fig. 5(a) and (b), the anode current saturates at the operating voltage from -2.0 to -5.0 kV in the conventional cathode case and from -3.9 to -5.0 kV in the shielded cathode case. These results indicate that the test magnetron was operated in the temperature-limited regime, where the current is determined by the cathode filament temperature and the work function of the filament material, independent of the operating voltage. Fig. 5(a) and (b) also shows that the anode current is dependent on the operating voltage when the operating voltage is -0.9 kV in the conventional cathode case and from -0.9 to -2.9 kV in the shielded cathode case. We confirmed that the test magnetron enters the space-charge-limited regime,

Fig. 5. Measured anode current distribution with no magnetic field applied. V_c is the operating voltage. (a) Conventional cathode (b) Shielded cathode.

according to the Child–Langmuir law [9], in these operating voltage ranges. Hence, we verified that the test magnetron functions like a cylindrical vacuum diode when no magnetic field is applied, as predicted in Section II-A.

Fig. 6(a) and (b) shows the anode current distribution of the test magnetron normalized by the total anode current I_{bt} for the conventional cathode and the shielded cathode, respectively. Installing the cathode shield causes the anode current to the central region to increase from 50% to 70% of the total anode current, whereas the anode current to the HV input side is reduced from 40% to 10% of the total anode current.

B. Case II: Applied Magnetic Field of 0.11 T

Figs. 7 and 8 show the measurement results for the anode current distribution and the anode current distribution normalized by the total anode current I_{bt} , respectively, as a function of the operating voltage. For both Figs. 7 and 8, the labels (a) and (b) indicate the results for the conventional cathode and the shielded cathode, respectively. The total anode current I_{bt} is 5.1 A in the conventional cathode case and 1.8 A in the shielded cathode case, respectively, both at the operating voltage of -5.0 kV. The relationship observed between the operating voltage and the total anode current indicates that the test magnetron was operated in the space-charge-limited regime when a magnetic field was applied.

As when no magnetic field was applied, a comparison of Fig. 8(a) and (b) shows that the anode current collected by anode C (central anode) is increased by shielding the cathode,

Fig. 6. Normalized anode current distribution (relative to the total anode current) with no magnetic field applied. V_c is the operating voltage. (a) Conventional cathode. (b) Shielded cathode.

whereas the anode current collected by anode I (HV input side) is reduced.

IV. DISCUSSION

A. Validity of the Test Magnetron Measurements

The measurement results reveal that when no magnetic field is applied to the test magnetron, it functions like a cylindrical vacuum diode in the temperature-limited regime. In this case, the current density of the electron emission J is derived from the Richardson–Dushman equation, i.e.,

$$J = AT_K^2 \exp(-e\phi/kT_K) \quad (1)$$

where A is the Richardson constant, T_K is the cathode temperature, e is the electron charge, k is the Boltzmann constant, and ϕ is the work function of the cathode material. Carburized thoriated tungsten was used for the cathode filament of the test magnetron. We previously measured the axial distribution of T_K (see [8]). The average filament temperatures in the regions adjacent to anode O, anode C, and anode I were measured to be approximately 1710, 1890, and 1870 K, respectively. The normalized current densities emitted from the three regions are calculated to be 10%, 49%, and 41%, respectively, which agrees reasonably well with the normalized anode current distribution shown in Fig. 6(a). This confirms that the test magnetron functions like a cylindrical vacuum diode when no magnetic field is applied.

Fig. 7. Measured anode current distribution when a magnetic field of 0.11 T is applied. V_c is the operating voltage. (a) Conventional cathode. (b) Shielded cathode.

The total anode current I_{bt} differs between the conventional cathode case and the shielded cathode case, as mentioned in Section III. This is probably due to a difference in the filament temperatures. For example, the current density J calculated using (1) decreases by 40% when the filament temperature is reduced from 1900 to 1850 K. Although we have not yet measured the axial temperature distribution of the shielded cathode filament, such a small filament temperature difference lies within the specification range, and the measured total anode currents in both cases were large enough for magnetron operation.

B. Leakage Current at Low Operating Voltages

Of particular interest in Fig. 8 is the anode current distribution at low operating voltages of -0.9 , -1.9 , and -2.9 kV. Note that a large amount of the anode current at the low operating voltages flows to the anode block on the RF output side (anode O) and the pole pieces. Hence, this anode current can be regarded as leakage current, which is unnecessary for proper magnetron operation. In particular, the normalized leakage current to the pole pieces is quite high at an operating voltage of -2.0 kV for both the conventional and shielded cathodes. On the other hand, the leakage current to the pole pieces is less than 2% of the total anode current when no magnetic field is applied. Thus, the measurement results indicate that electrons

Fig. 8. Normalized anode current distribution (relative to the total anode current) when a magnetic field of 0.11 T is applied. V_c is the operating voltage. (a) Conventional cathode. (b) Shielded cathode.

are diffused in the axial direction when a magnetic field is applied.

The leakage current to the pole pieces is attributed to the electric field generated by the space charge. The electron motion in a magnetron is governed by the Lorentz force and Poisson's equation. We assume that the RF electromagnetic field can be neglected at low operating voltages where oscillation does not occur, because electrons in the interaction space are affected little by the RF field. Under this assumption, the Lorentz force generated by the applied operating voltage, the applied magnetic field, and the electron density ρ in the interaction space is given by

$$m \frac{d\mathbf{v}}{dt} = -e(\mathbf{E} + \mathbf{v} \times \mathbf{B}) \quad (2)$$

and Poisson's equation can be written as

$$\nabla \cdot \mathbf{E} = \rho / \epsilon_0 \quad (3)$$

where m is the electron mass, $\mathbf{E}$ is the electric field, $\mathbf{v}$ is the electron velocity, $\mathbf{B}$ is the applied magnetic field, and ϵ_0 is the electric permittivity. Note that the axial electron motion is ideally independent of $\mathbf{B}$ when a magnetic field is perfectly applied in the axial direction, i.e., $\mathbf{B} = B_z$, where z indicates the axial direction.

Here, we analyze the axial diffusion effect derived from (2) and (3) in a magnetron on a planar electron beam, as depicted

Fig. 9. Cross-sectional diagram of a planar beam. r_a is the anode position, r_c is the cathode position, V is the anode-cathode voltage, I is the current density, and $\pm z_0$ is the end position of the planar beam in the z -direction on the cathode.

in Fig. 9. Although this analysis only provides an order-of-magnitude estimate, it allows us to analytically analyze the axial diffusion effect. The envelope curve of the planar beam in the rz plane is expressed by the following equation [10], [11]:

$$z = \pm \frac{I}{V^{\frac{3}{2}}} \frac{\sqrt{m/e}}{2^{\frac{7}{2}} \varepsilon_0} (r - r_c)^2 \pm z_0 \quad (4)$$

where r_a is the anode position, r_c is the cathode position, V is the anode-cathode voltage, I is the current density in the r -direction, and $\pm z_0$ is the end position of the planar beam in the z -direction on the cathode, as shown in Fig. 9. Utilizing the measurement data, V is the operating voltage at the anode radius r_a , and I is roughly estimated to be 300 A/m by dividing the total anode current by the cathode length (about 10 mm) when no magnetic field is applied. From the test magnetron case, substituting $I = 300$ A/m, $V = 1$ kV, and $(r_a - r_c) = 2.5$ mm into (4) results in an electron axial diffusion length on the order of 1 mm for the case when no magnetic field is applied. When a magnetic field is applied, electrons are diffused much further in the axial direction, because the effective travel time from the cathode to the anode is much longer than when no magnetic field is applied (i.e., the cylindrical diode case). Thus, when a magnetic field is applied, a significant amount of leakage current is expected to reach the pole pieces, as the measurement confirms.

The relationship between the observed leakage current at low operating voltages and start-up noise generation is still under investigation; however, the method presented in this paper for measuring the leakage current using segmented anode blocks should prove valuable in understanding how electron motion in the axial direction affects start-up noise in relativistic magnetrons and oven magnetrons.

C. Role of the Cathode Shield

As shown in Figs. 6 and 8, the anode current is mostly concentrated in the central region of the anode when a metal cathode shield is installed. In other words, the cathode shield prevents electrons from flowing to the ends, opposing the effect of axial diffusion.

Here, we discuss the electron motion in the vicinity of the anode ends. The electric field due to the operating voltage consists of radial and axial components at both anode ends due to end effects at the anode block or the cathode end hats, whereas it is aligned in the radial direction in the central region of the anode. Magnetron oscillation occurs through synchronization between the RF field generated by the anode resonant cavities and the $\mathbf{E} \times \mathbf{B}$ drift motion of electron spokes. Hence, pure oscillation must arise in the region where the electric and magnetic field are aligned in the radial and axial directions, respectively. In contrast, undesired electric or magnetic fields will create electron motions that will generate undesirable RF noise.

V. CONCLUSION

The anode current distribution has been measured in an oven magnetron to evaluate the role of the cathode shield. A test magnetron with and without a cathode shield has been measured. In each case, the magnetron under test has been measured both with no applied magnetic field and with an applied magnetic field of 0.11 T. Measurements show that the cathode shield increases the normalized anode current collected in the central anode region, where the electric and magnetic fields are almost ideally “crossed,” and prevents electrons from flowing to the anode ends. This results in enhanced pure oscillation and reduced unwanted noise. Measurements also show that an applied magnetic field can result in a significantly higher leakage current on the magnetron pole pieces due to greater axial diffusion of electrons. Future development may include confirmation of the noise reduction and minimization of start-up noise using detailed particle-in-cell simulations.

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